

8961726 TEXAS INSTR (OPTO)

62C 37019 D

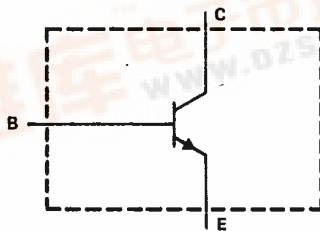
TIPL752, TIPL752A
N-P-N SILICON POWER TRANSISTORS

7-33-13

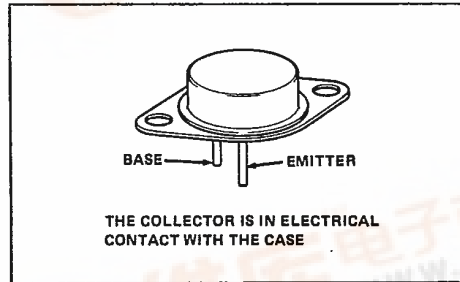
OCTOBER 1982 - REVISED OCTOBER 1984

- 150 W at 25°C Case Temperature
- 6 A Continuous Collector Current
- 12 A Peak Collector Current
- Operating Characteristics Fully Guaranteed at 100°C
- Transient Power Dissipation Guaranteed at 100°C
- $I_{CES} < 100 \mu A$ at Maximum Rated V_{CE} at 100°C
- 1000 V Blocking Capability
- High Sustaining Voltage
TIPL752 . . . 350 V Min.
TIPL752A . . . 400 V Min.
- Specifically Designed for High-Voltage, Inductive-Load Switching Applications

device schematic



TO-3 PACKAGE



absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIPL752	TIPL752A
Collector-base voltage	800 V	1000 V
Collector-emitter voltage ($V_{BE} = 0$)	800 V	1000 V
Collector-emitter voltage ($I_B = 0$)	350 V	400 V
Base-emitter voltage	10 V	
Continuous collector current	6 A	
Peak collector current (see Note 1)	12 A	
Continuous device dissipation at (or below) 25°C case temperature (see Figure 12)	150 W	
Operating junction and storage temperature range	-65°C to 200°C	

NOTE 1: This value applies for $t_W \leq 10$ ms, duty cycle $\leq 2\%$.

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TIPL752, TIPL752A
N-P-N SILICON POWER TRANSISTORS

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electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIPL752		TIPL752A		UNIT
		MIN	TYP MAX	MIN	TYP MAX	
V _{CEO(sus)}	I _C = 0.1 A, L = 25 mH, See Note 2	350		400		V
I _{CEO}	V _{CE} = 350 V, I _B = 0	50				μA
	V _{CE} = 400 V, I _B = 0			50		
I _{CES}	V _{CE} = 800 V, V _{BE} = 0	50				μA
	V _{CE} = 1000 V, V _{BE} = 0			50		
	V _{CE} = 800 V, V _{BE} = 0, T _C = 100°C	100				
	V _{CE} = 1000 V, V _{BE} = 0, T _C = 100°C			100		
I _{EBO}	V _{EB} = 10 V, I _C = 0	1		1		mA
h _{FE}	V _{CE} = 5 V, I _C = 0.5 A, See Notes 3 and 4	15	60	15	60	
V _{CE(sat)}	I _C = 2 A, I _B = 0.4 A, See Notes 3 and 4	0.5		0.5		V
	I _C = 4 A, I _B = 0.8 A, See Notes 3 and 4	1		1		
	I _C = 6 A, I _B = 1.2 A, See Notes 3 and 4	2.5		2.5		
	I _C = 6 A, I _B = 1.2 A, See Notes 3 and 4, T _C = 100°C	5		5		
V _{BE(sat)}	I _C = 2 A, I _B = 0.4 A, See Notes 3 and 4	1.1		1.1		V
	I _C = 4 A, I _B = 0.8 A, See Notes 3 and 4	1.3		1.3		
	I _C = 6 A, I _B = 1.2 A, See Notes 3 and 4	1.5		1.5		
	I _C = 6 A, I _B = 1.2 A, See Notes 3 and 4, T _C = 100°C	1.4		1.4		
f _T	V _{CE} = 10 V, I _C = 0.5 A, See Note 5	7		7		MHz
C _{obo}	V _{CB} = 20 V, I _E = 0, f = 0.1 MHz	105		105		pF

- NOTES: 2. Inductive loop switching measurement.
 3. These parameters are measured using pulse techniques, pulse duration = 300 μs, duty cycle < 2%.
 4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts and located within 3,2 mm (0.125 inch) from the device body.
 5. To obtain f_T, the |h_{fe}| response is extrapolated at the rate of -6 dB per octave from f = 1 MHz to the frequency at which |h_{fe}| = 1.

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thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$		1.17		°C/W

resistive-load switching characteristics (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{on}	$I_C = 6A, V_{CC} = 200V, I_{B1} = 1.2A,$ $I_{B2} = -1.2A, T_C = 25^\circ C,$ See Figure 1			1	μs
t_s				2.5	μs
t_f				0.46	μs
t_{on}	$I_C = 6A, V_{CC} = 200V, I_{B1} = 1.2A,$ $I_{B2} = -1.2A, T_C = 100^\circ C,$ See Figure 1			2.5	μs
t_s				3	μs
t_f				1	μs

inductive-load switching characteristics (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{sv}	$I_C = 6A, I_{B1} = 1.2A, T_C = 25^\circ C,$ $V_{BE(off)} = -10V,$ See Figure 2			2.5	μs
t_{rv}				200	ns
t_{fi}				150	ns
t_{tj}				50	ns
t_{xo}				300	μs
t_{sv}	$I_C = 6A, I_{B1} = 1.2A, T_C = 100^\circ C,$ $V_{BE(off)} = -10V,$ See Figure 2			3	μs
t_{rv}				300	ns
t_{fi}				150	ns
t_{tj}				50	ns
t_{xo}				500	ns

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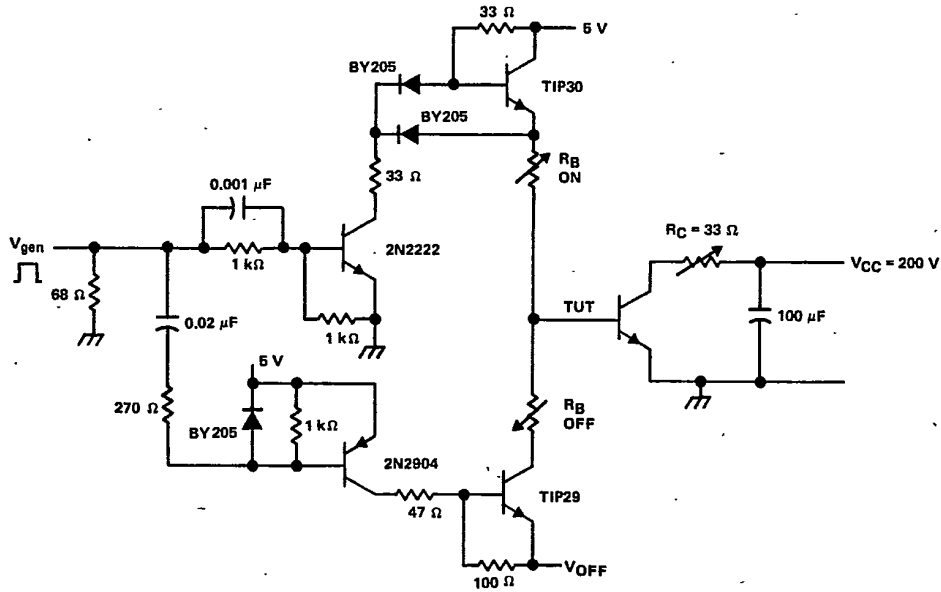
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N-P-N SILICON POWER TRANSISTORS

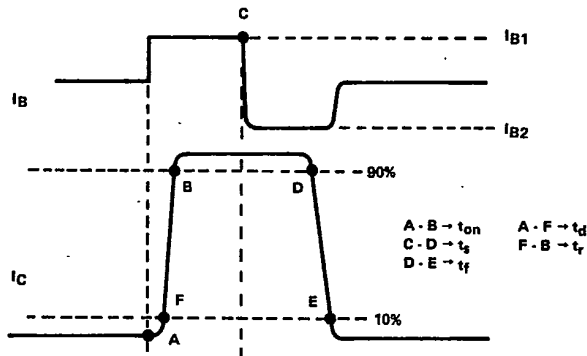
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PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT

TIPL Devices



CURRENT WAVEFORMS

- NOTES: A. The V_{gen} waveform is supplied by the following characteristics: $t_r < 15$ ns, $t_f < 15$ ns, $Z_{out} = 50 \Omega$, $t_W = 20 \mu s$, duty cycle $\leq 2\%$.
 B. Waveforms are monitored on an oscilloscope with the following characteristics: $t_r < 15$ ns, $R_{in} > 10$ M Ω , $C_{in} < 11.5$ pF.
 C. Resistors must be noninductive types.

FIGURE 1. RESISTIVE-LOAD SWITCHING

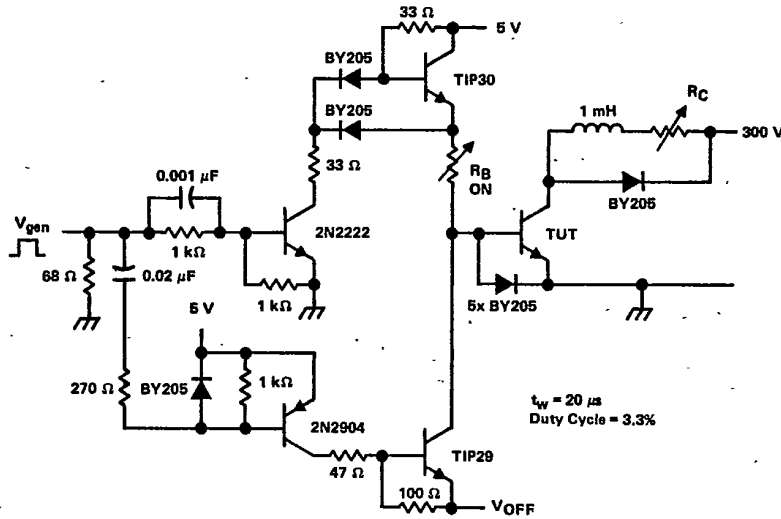
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TIPL752, TIPL752A
N-P-N SILICON POWER TRANSISTORS

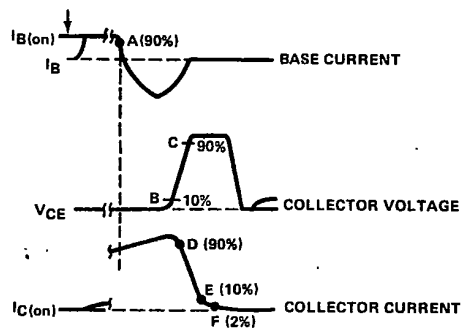
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PARAMETER MEASUREMENT INFORMATION



ADJUST R_C FOR REQUIRED I_C

TEST CIRCUIT



VOLTAGE AND CURRENT WAVEFORMS

NOTES: A. Waveforms are monitored on an oscilloscope with the following characteristics: $t_r \leq 15$ ns, $R_{in} \geq 10$ M Ω , $C_{in} \leq 11.5$ pF.
B. Resistors must be noninductive types.

A-B = t_{BV}
A-C = t_{TV}
D-E = t_{fi}
E-F = t_{ti}
B-E = t_{XO}

FIGURE 2. INDUCTIVE-LOAD SWITCHING

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TYPICAL CHARACTERISTICS

RESISTIVE-LOAD TURN-OFF TIME
vs
BASE CUTOFF CURRENT

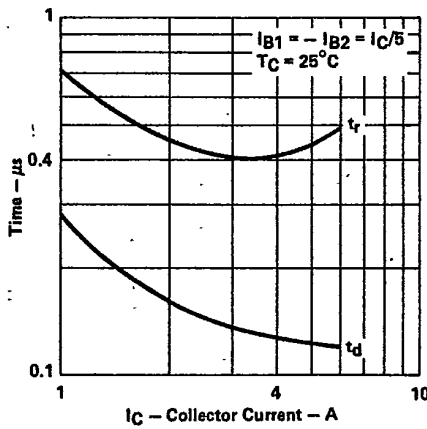


FIGURE 3

RESISTIVE-LOAD TURN-OFF TIME
vs
COLLECTOR CURRENT

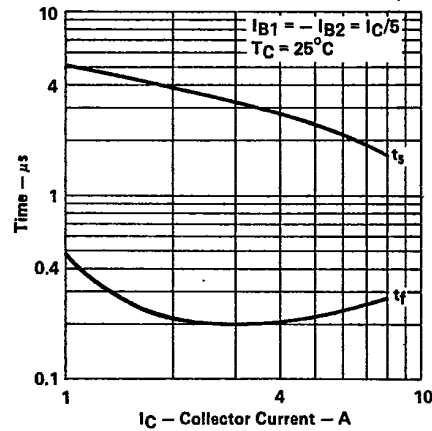


FIGURE 4

COLLECTOR-EMITTER SATURATION VOLTAGE
vs
BASE CURRENT

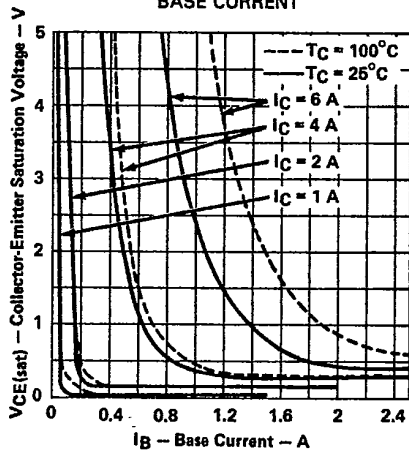


FIGURE 5

BASE-EMITTER SATURATION VOLTAGE
vs
BASE CURRENT

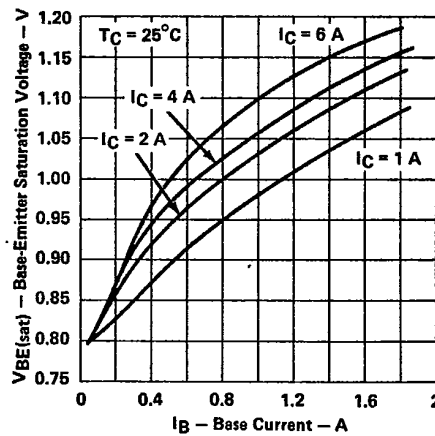


FIGURE 6

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TYPICAL CHARACTERISTICS

FORWARD CURRENT TRANSFER RATIO
vs
COLLECTOR CURRENT

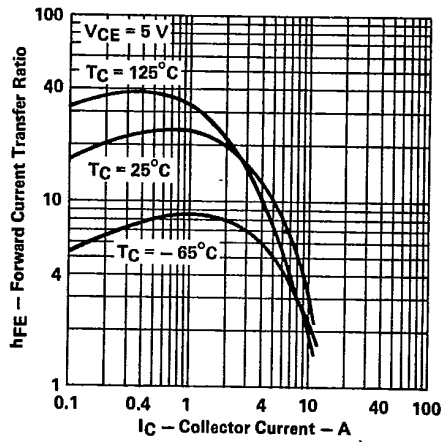


FIGURE 7

COLLECTOR CUTOFF CURRENT
vs
CASE TEMPERATURE

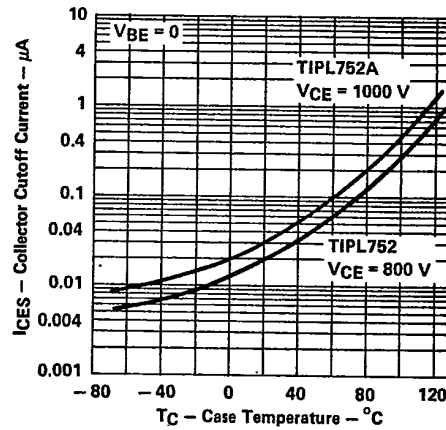


FIGURE 8

MAXIMUM SAFE OPERATING AREA

FORWARD-BIAS SAFE OPERATING AREA

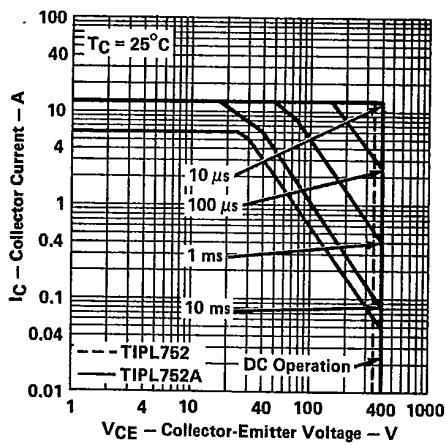


FIGURE 9

LIMITING CONDITIONS
FOR POWER-DOWN TRANSIENT

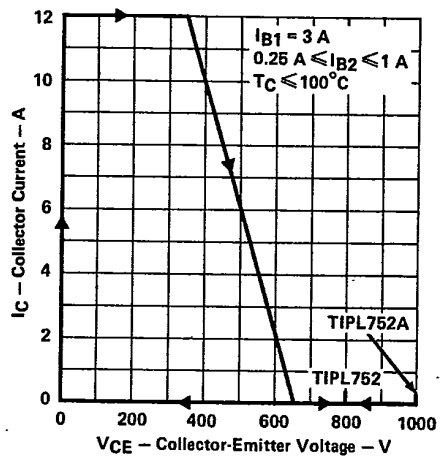


FIGURE 10

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THERMAL INFORMATION

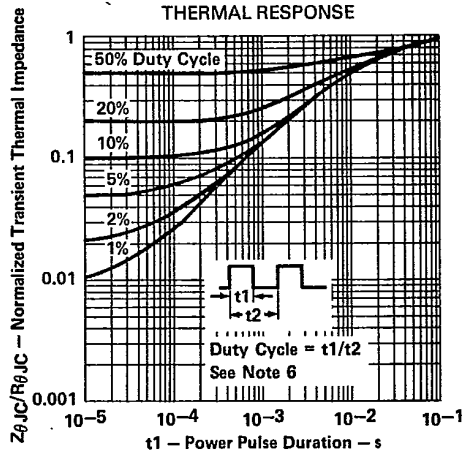


FIGURE 11

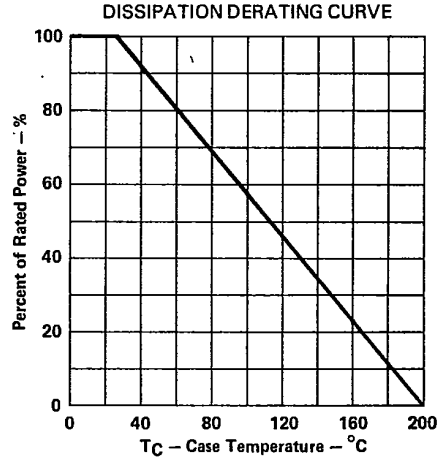


FIGURE 12

NOTE 6: Read time at end of t_1 . $T_J(\max) - T_C = P_D(\text{peak}) \cdot \left(\frac{Z_{\theta JC}}{R_{\theta JC}} \right) \cdot R_{\theta JC}(\max)$.

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